

Notice of References Cited	Application/Control No. 10/072,980		Applicant(s)/Patent Under Reexamination CHIU ET AL.	
	Examiner Linda Krisciunas		Art Unit 3623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,666,496	09-1997	Wojcik et al	705/26
*	B	US-2005/0177435	08-2005	Lidow, Derek	705/022
*	C	US-2003/0014318	01-2003	DE LA MOTTE et al.	705/26
*	D	US-6,704,612	03-2004	Hahn-Carlson, Dean W.	700/213
*	E	US-2003/0149578	08-2003	Wong, Yek-Meng	705/1
*	F	US-2002/0069096	06-2002	Lindoefer et al.	705/7
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	ASTM Standards Listing (6 pages)
	V	Department of Defense Acquisition Regulations, February 14, 1991.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.